

Dual N-Channel 1.5-V (G-S) MOSFET

PRODUCT SUMMARY			
V _{DS} (V)	r _{DS(on)} (Ω)	I _D (A)	Q _g (Typ)
8	0.032 at V _{GS} = 4.5 V	4 ^a	7.3 nC
	0.036 at V _{GS} = 2.5 V	4 ^a	
	0.045 at V _{GS} = 1.8 V	4 ^a	
	0.054 at V _{GS} = 1.5 V	4 ^a	

FEATURES

- TrenchFET[®] Power MOSFET: 1.5 V Rated
- Ultra -low on-resistance in compact, thermally enhanced ChipFET[®] package

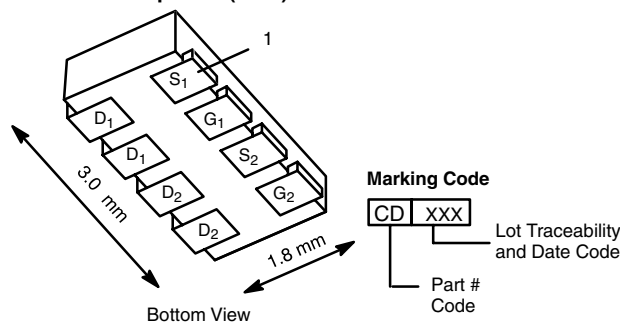


RoHS
COMPLIANT

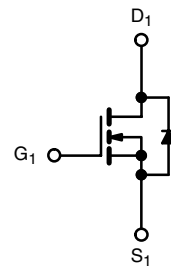
APPLICATIONS

- Load switch for portable applications
 - Guaranteed operation at V_{GS} = 1.5 V critical for optimized design and space savings

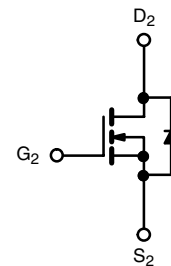
1206-8 ChipFET[®] (Dual)



Ordering Information: Si5920DC-T1-E3 (Lead (Pb)-free)



N-Channel MOSFET



N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS T _A = 25 °C, unless otherwise noted			
Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V _{DS}	8	V
Gate-Source Voltage	V _{GS}	± 5	
Continuous Drain Current (T _J = 150 °C)	I _D	T _C = 25 °C	4 ^a
		T _C = 70 °C	4 ^a
		T _A = 25 °C	4 ^a
		T _A = 70 °C	4 ^a
Pulsed Drain Current	I _{DM}	25	A
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C	
		T _A = 25 °C	1.7 ^c
Maximum Power Dissipation	P _D	T _C = 25 °C	3.12
		T _C = 70 °C	2.0
		T _A = 25 °C	2.04 ^{b, c}
		T _A = 70 °C	1.3 ^{b, c}
Operating Junction and Storage Temperature Range	T _J , T _{stg}	- 55 to 150	°C
Soldering Recommendations (Peak Temperature) ^{d, e}		260	

THERMAL RESISTANCE RATINGS					
Parameter	Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{b, f}	R _{thJA}	50	60	°C/W	
Maximum Junction-to-Foot (Drain)	R _{thJF}	30	40		

Notes:

- Package limited.
- Surface Mounted on 1" x 1" FR4 Board.
- t = 5 sec.
- See Solder Profile (<http://www.vishay.com/ppg?73257>). The 1206-8 ChipFET is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.
- Maximum under Steady State conditions is 90 °C/W.

SPECIFICATIONS $T_J = 25\text{ }^\circ\text{C}$, unless otherwise noted						
Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Static						
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0\text{ V}, I_D = 250\text{ }\mu\text{A}$	8			V
V_{DS} Temperature Coefficient	$\Delta V_{DS}/T_J$	$I_D = 250\text{ }\mu\text{A}$		8.2		mV/°C
$V_{GS(th)}$ Temperature Coefficient	$\Delta V_{GS(th)}/T_J$			-2.6		
Gate-Source Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250\text{ }\mu\text{A}$	0.3		1	V
Gate-Source Leakage	I_{GSS}	$V_{DS} = 0\text{ V}, V_{GS} = \pm 5\text{ V}$			± 100	ns
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 8\text{ V}, V_{GS} = 0\text{ V}$			1	μA
		$V_{DS} = 8\text{ V}, V_{GS} = 0\text{ V}, T_J = 55\text{ }^\circ\text{C}$			10	
On-State Drain Current ^a	$I_{D(on)}$	$V_{DS} \leq 5\text{ V}, V_{GS} = 4.5\text{ V}$	25			A
Drain-Source On-State Resistance ^a	$r_{DS(on)}$	$V_{GS} = 4.5\text{ V}, I_D = 6.8\text{ A}$		0.025	0.032	Ω
		$V_{GS} = 2.5\text{ V}, I_D = 6.3\text{ A}$		0.0285	0.036	
		$V_{GS} = 1.8\text{ V}, I_D = 2.5\text{ A}$		0.036	0.045	
		$V_{GS} = 1.5\text{ V}, I_D = 1.8\text{ A}$		0.041	0.054	
Forward Transconductance ^a	g_{fs}	$V_{DS} = 4\text{ V}, I_D = 6.8\text{ A}$		18		S
Dynamic^b						
Input Capacitance	C_{iss}	$V_{DS} = 4\text{ V}, V_{GS} = 0\text{ V}, f = 1\text{ MHz}$		680		pF
Output Capacitance	C_{oss}			230		
Reverse Transfer Capacitance	C_{rss}			140		
Total Gate Charge	Q_g	$V_{DS} = 4\text{ V}, V_{GS} = 5\text{ V}, I_D = 6.8\text{ A}$		8	12	nC
		$V_{DS} = 4\text{ V}, V_{GS} = 4.5\text{ V}, I_D = 6.8\text{ A}$		7.3	11	
Q_{gs}			0.84			
Q_{gd}			1.26			
Gate Resistance	R_g	$f = 1\text{ MHz}$		1.8	2.7	Ω
Turn-On Delay Time	$t_{d(on)}$	$V_{DD} = 4\text{ V}, R_L = 0.73\text{ }\Omega$ $I_D \cong 5.5\text{ A}, V_{GEN} = 4.5\text{ V}, R_g = 1\text{ }\Omega$		8	12	ns
Rise Time	t_r			11	17	
Turn-Off Delay Time	$t_{d(off)}$			18	27	
Fall Time	t_f			7	11	
Drain-Source Body Diode Characteristics						
Continuous Source-Drain Diode Current	I_S	$T_C = 25\text{ }^\circ\text{C}$			2.6	A
Pulse Diode Forward Current	I_{SM}				25	
Body Diode Voltage	V_{SD}	$I_S = 2.6\text{ A}, V_{GS} = 0\text{ V}$		0.8	1.2	V
Body Diode Reverse Recovery Time	t_{rr}	$I_F = 2.6\text{ A}, di/dt = 100\text{ A}/\mu\text{s}, T_J = 25\text{ }^\circ\text{C}$		12	18	ns
Body Diode Reverse Recovery Charge	Q_{rr}			3	5	nC
Reverse Recovery Fall Time	t_a			7		ns
Reverse Recovery Rise Time	t_b			5		

Notes:

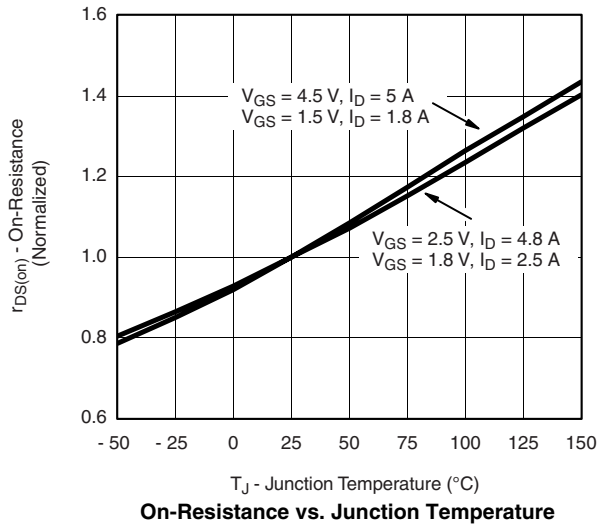
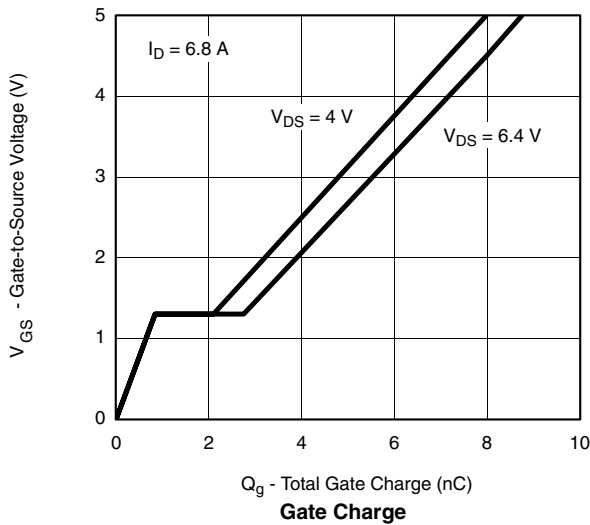
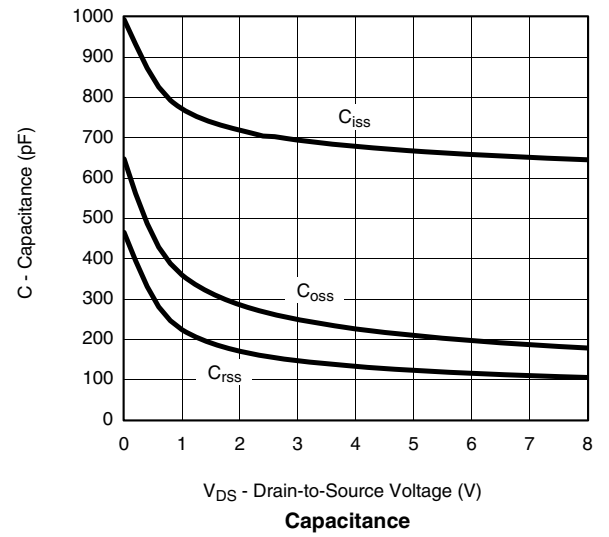
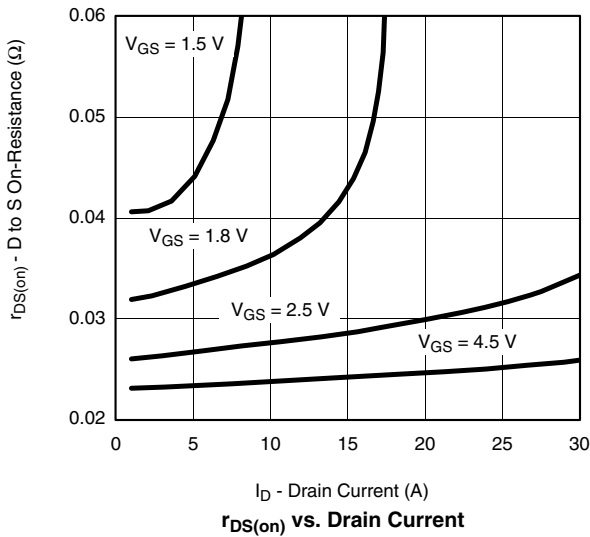
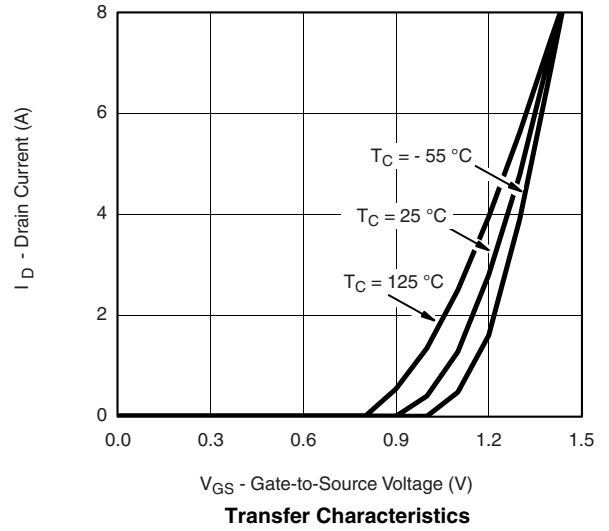
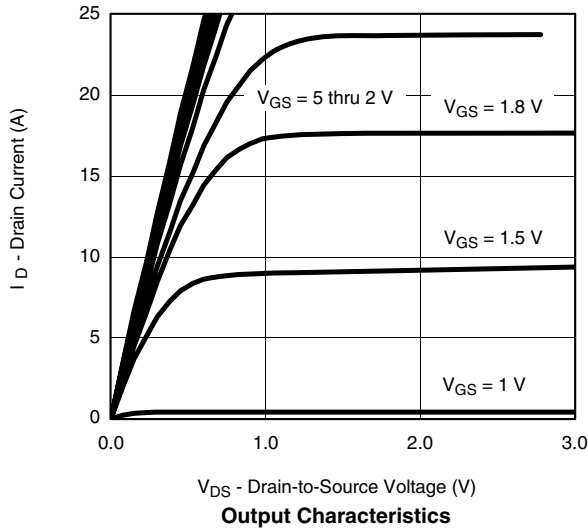
a. Pulse test; pulse width $\leq 300\text{ }\mu\text{s}$, duty cycle $\leq 2\%$.

b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

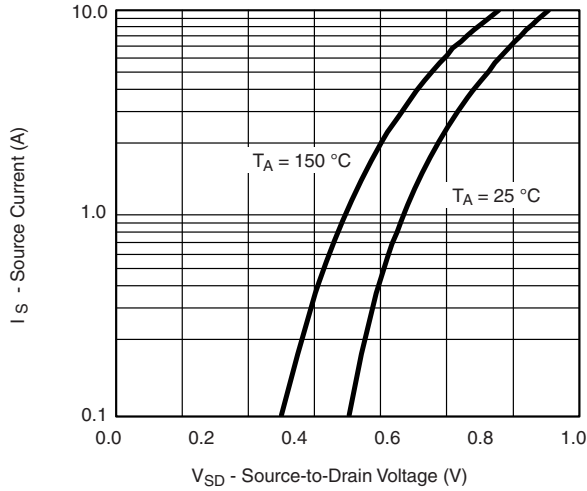


TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

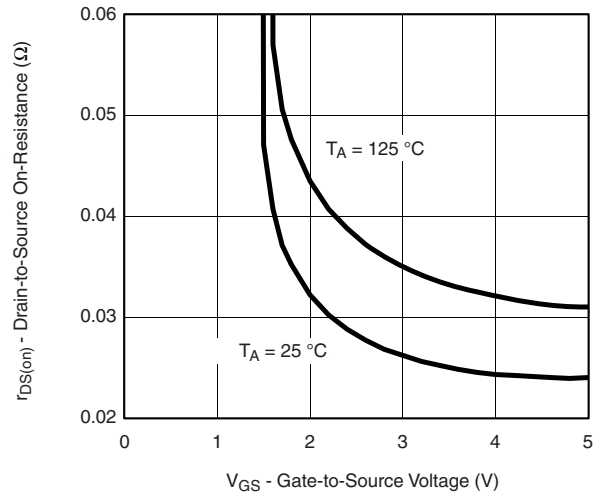




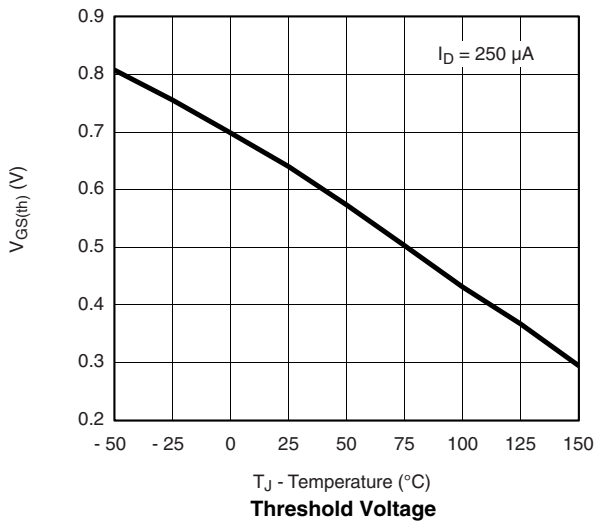
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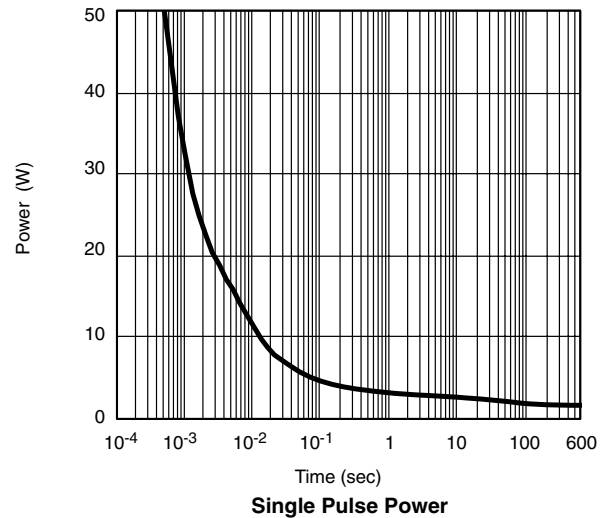
Forward Diode Voltage vs. Temp



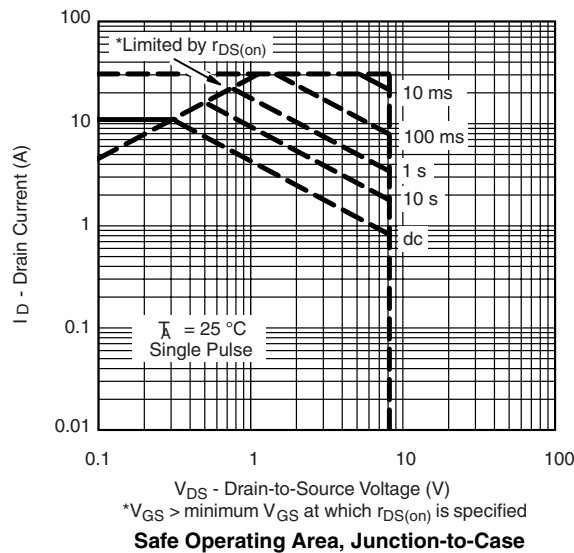
r_{DS(on)} vs. V_{GS} vs. Temperature



Threshold Voltage



Single Pulse Power

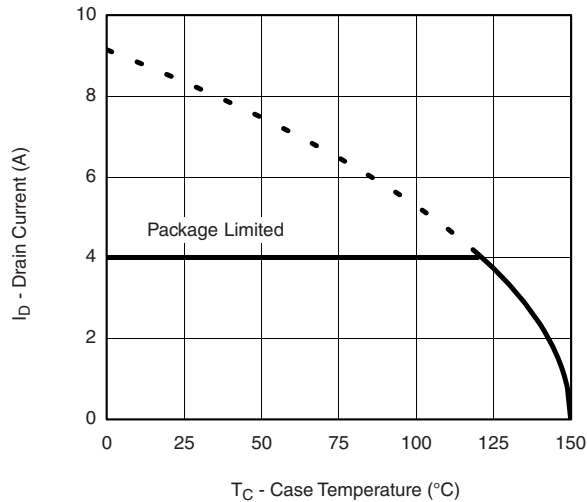


*V_{GS} > minimum V_{GS} at which r_{DS(on)} is specified

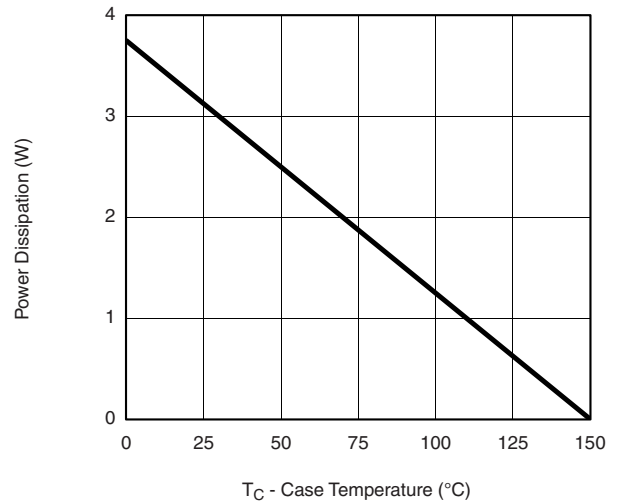
Safe Operating Area, Junction-to-Case



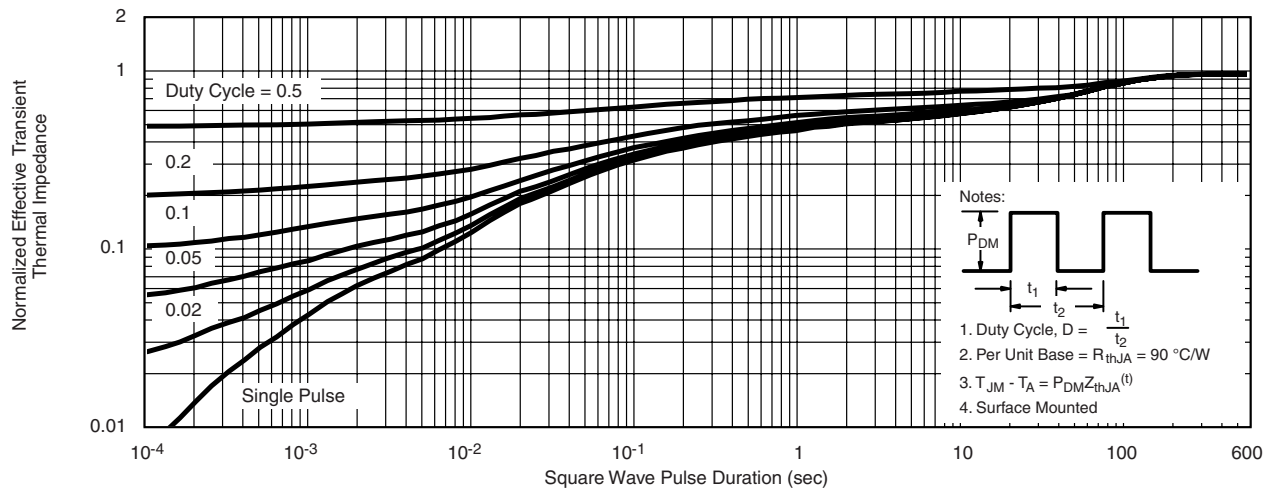
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Current Derating*



Power Derating

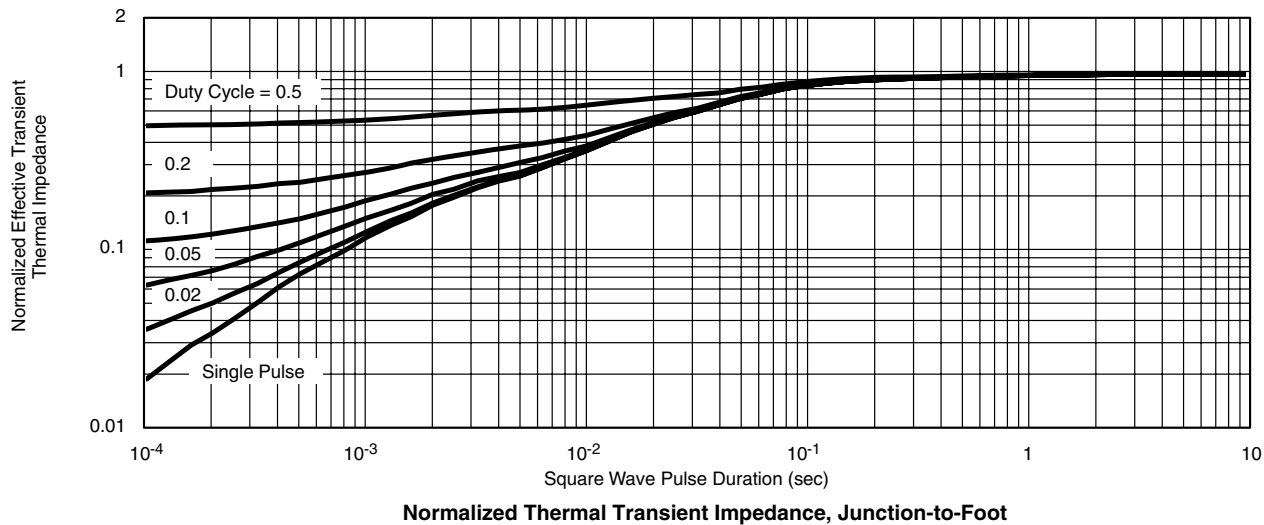


Normalized Thermal Transient Impedance, Junction-to-Ambient

*The power dissipation P_D is based on $T_{J(max)} = 150 \text{ }^\circ\text{C}$, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



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